

Dual-benefit strategy for developing an efficient photodetector with prompt response to UV-near IR radiations: *in situ* synthesis and crystallization through a simple one-step annealing

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Figure S1

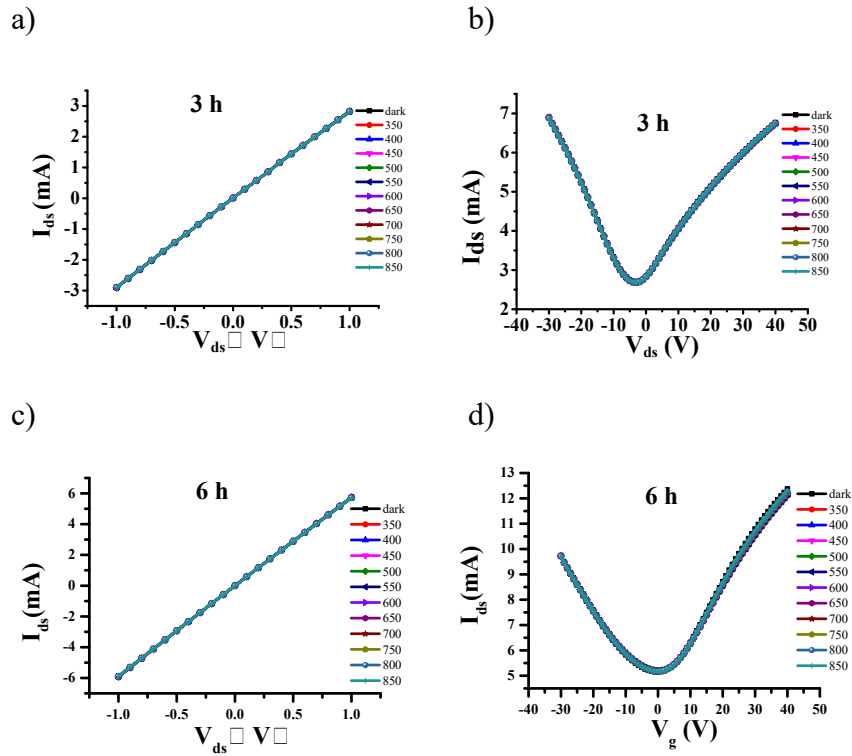


Figure S1 Typical  $I_{ds}$ - $V_{ds}$  ( $V_g=0$  V) and  $I_{ds}$ - $V_g$  curves ( $V_{ds}=1$  V) of 3 h (a and b) and 6 h (c and d) C8-DPP-BP/G phototransistors in dark and upon radiations. Incident power density ( $P_{in}$ ) of radiations in (a-d) :  $P_{in}$  (350 nm)= 0.48 mW cm<sup>-2</sup>,  $P_{in}$  (400 nm)= 0.63 mW cm<sup>-2</sup>,  $P_{in}$  (450 nm)= 0.7 mW cm<sup>-2</sup>,  $P_{in}$  (500 nm)= 0.68 mW cm<sup>-2</sup>,  $P_{in}$  (550 nm)= 0.51 mW cm<sup>-2</sup>,  $P_{in}$  (600 nm)= 0.37 mW cm<sup>-2</sup>,  $P_{in}$  (650 nm)= 0.26 mW cm<sup>-2</sup>,  $P_{in}$  (700 nm)= 0.19 mW cm<sup>-2</sup>,  $P_{in}$  (750 nm)= 0.14 mW cm<sup>-2</sup>,  $P_{in}$  (800 nm)= 0.1 mW cm<sup>-2</sup>,  $P_{in}$  (850 nm)= 0.08 mW cm<sup>-2</sup>.

Table S1 R and D\* values in part of current researches and this work

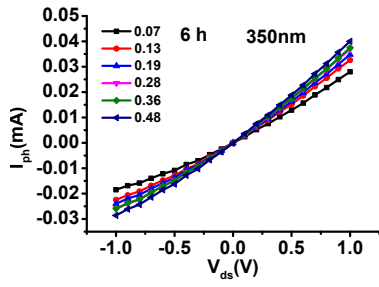
Materials	R (A W <sup>-1</sup> )	D* (Jones)	Wavelength, Power or power density
6 h C8-DPP-BP/G (this work)	100-350	1-3*10 <sup>11</sup>	350-850 nm, 0.08-0.7 mW cm <sup>-2</sup>
G/h-BN/PTCDI C13/G <sup>1</sup>	- 180	10 <sup>10</sup>	550 nm, 13.7 mW cm <sup>-2</sup>
PTCDI-C8/G <sup>2</sup>	~0.1 <sup>a</sup>	~10 <sup>10, a</sup>	480 nm, 0.001 mW
G/C <sub>60</sub> /pentacene <sup>3</sup>	~100-1000	-	405-1550 nm, 1-0.1 mW cm <sup>-2</sup>
Perovskite/G <sup>4</sup>	~100 <sup>a</sup>	~10 <sup>9, a</sup>	520 nm, 0.001 mW
G/rhodamine film/G <sup>5</sup>	6G 500	-	520 nm, 0.1 mW
C <sub>60</sub> /G <sup>6</sup>	~100-1000 <sup>a</sup>	-	360-808 nm, 100 nW
Thieno[3,4- b]thiophene/benzodithi ophene/G <sup>7</sup>	~100-1000 <sup>a</sup>	-	White-light emitting diodes, 1-0.1 mW cm <sup>-2</sup>
C <sub>60</sub> /Zn phthalocyanine/G <sup>8</sup>	~10-1000 <sup>a</sup>	-	650 nm, 1-0.1 mW cm <sup>-2</sup>
2,6-diphenyl anthracene/G <sup>9</sup>	~10-100 <sup>b</sup>	10 <sup>13</sup>	Xenon lamp, 0.62 mW cm <sup>-2</sup>

a: Estimated from the R (D\*)-power or power density curves

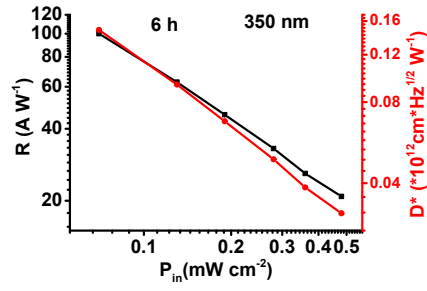
b: Estimated from the R-V<sub>g</sub> curve

Figure S2

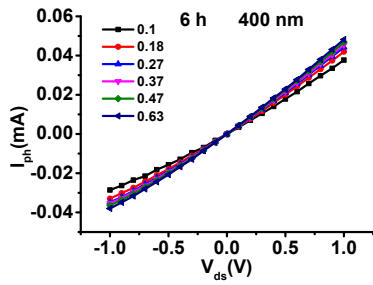
a)



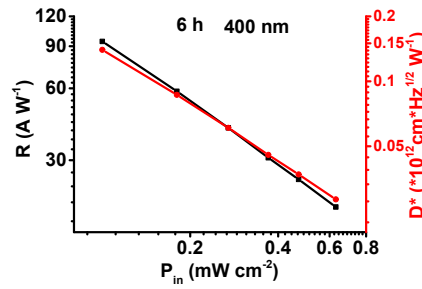
b)



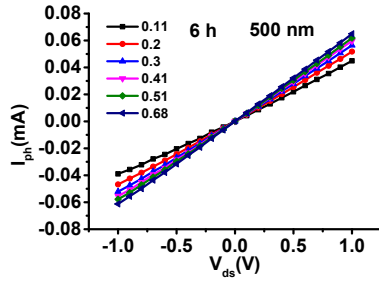
c)



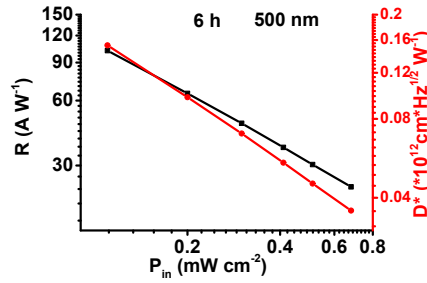
d)



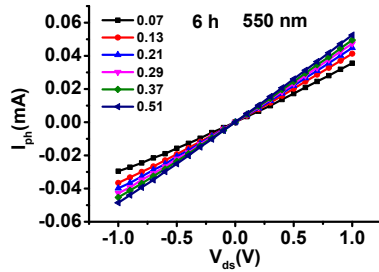
e)



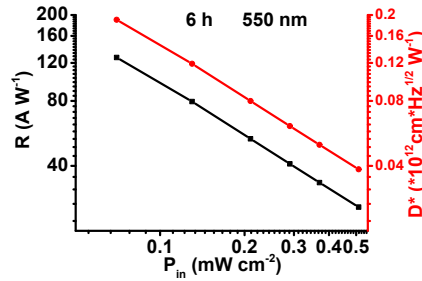
f)



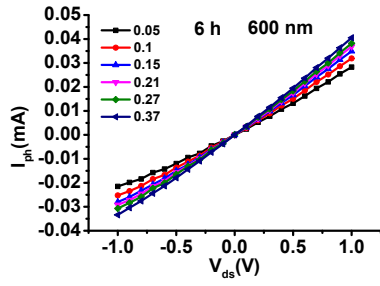
g)



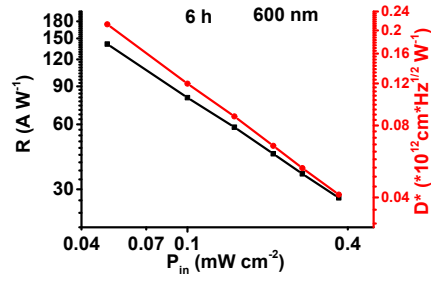
h)



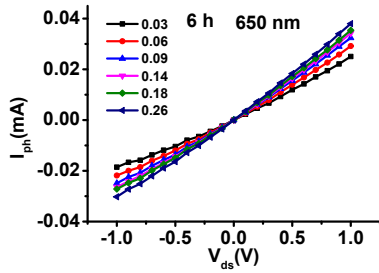
i)



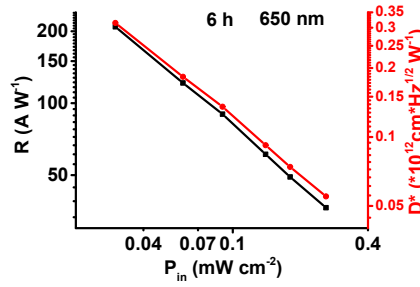
j)



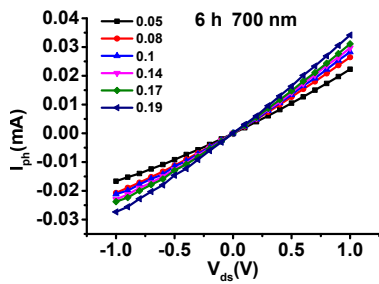
k)



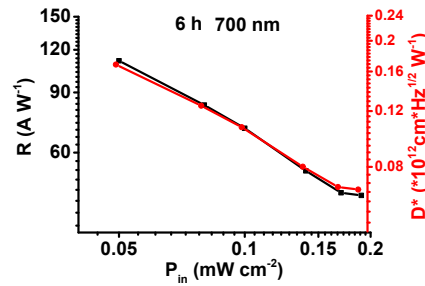
l)



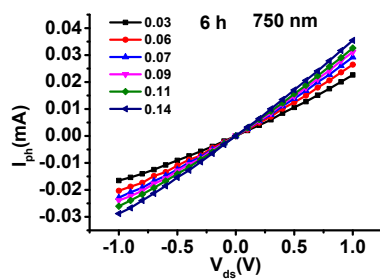
m)



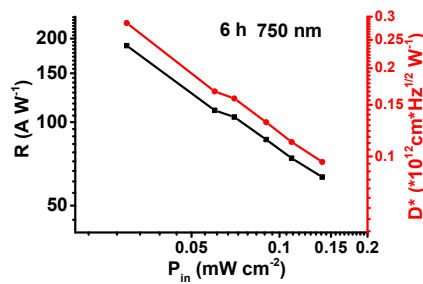
n)



o)



p)



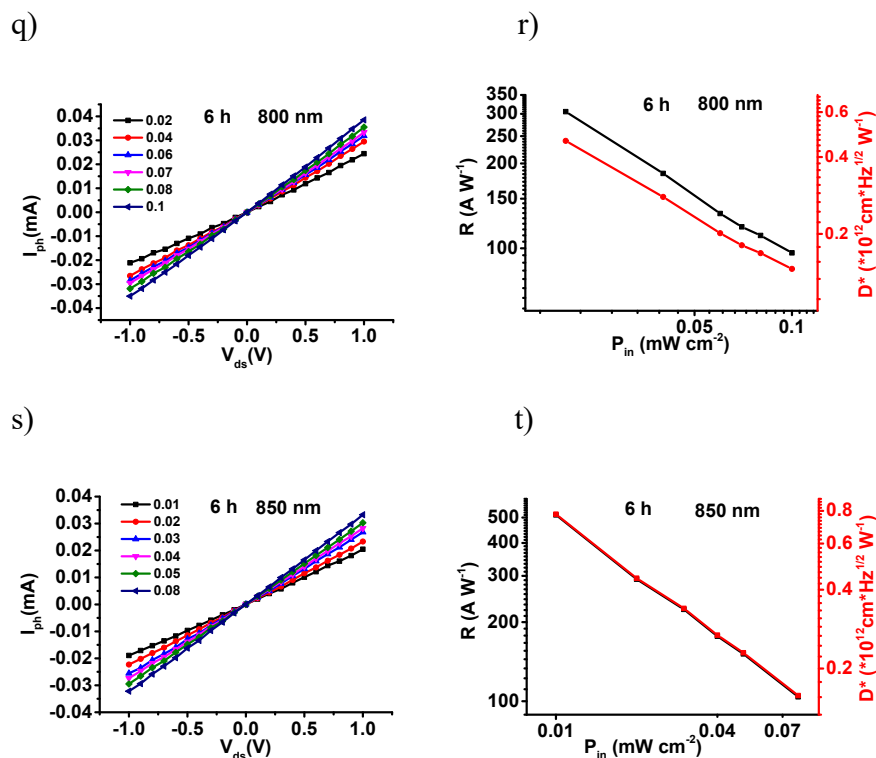


Figure S2 Typical  $I_{ph}$ - $V_{ds}$  curves at different  $P_{in}$  ( $mW\ cm^{-2}$ ,  $V_g=0\ V$ ) and  $R/D^*$ -  $P_{in}$  lines (bilogarithmical scales,  $V_{ds}=1\ V$ ,  $V_g=0\ V$ ) of 6 h C8-DPP-BP/G phototransistors.

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